

**Notice of References Cited**

Application/Control No.

10/027,919

Applicant(s)/Patent Under  
Reexamination  
SEITA ET AL.

Examiner

Edna Wong

GW 429103

Art Unit

1753

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,384,930	05-1983	Eckles, William E.	205/253
	B	US-4,469,564	09-1984	Okinaka et al.	205/125
	C	US-6,355,153	03-2002	Uzoh et al.	205/87
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2264717 A	09-1993	United Kingdom	JACOBS, LOUW	C25D 03/38
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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